FCC
TEST REPORT

Prepared for :

EDA Technology Shanghai Co.,Ltd

Building 29, Shengchuang Enterprise Park, No.1661 Jialuo Road, Jiading District, Shanghai, PRC

Product Name:	**ED-CLAWBOX**
Trade Mark:	**EDATEC**
Product Model (S):	**ED-CLAWBOX**
Date of Test:	**Aug. 11, 2026 – Aug. 26, 2026**
Date of Report:	**Aug. 26, 2026**
Report Number:	**HK2608110813-1ER**

Prepared By :

Shenzhen HUAK Testing Technology Co., Ltd.

1-2/F., Building B2, Junfeng Zhongcheng Zhizao Innovation Park, Heping, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

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TEST REPORT

Applicant	:	EDA Technology Shanghai Co.,Ltd
Address	:	Building 29, Shengchuang Enterprise Park, No.1661 Jialuo Road, Jiading District, Shanghai, PRC
Manufacturer	:	EDA Technology Shanghai Co.,Ltd
Address	:	Building 29, Shengchuang Enterprise Park, No.1661 Jialuo Road, Jiading District, Shanghai, PRC
Product Name	:	ED-CLAWBOX
(A) Product Model	:	ED-CLAWBOX
(B) Series Model	:	N/A
(C) Power Supply	:	DC 5V (Voltage operating range: DC 4.75V ~ DC 5.25V)

Standards..... FCC Part 15 Subpart B
ANSI C63.4

This device described above has been tested by HUAK, and the test results show that the equipment under test (EUT) is in compliance with Part 15 of FCC Rules. And it is applicable only to the tested sample identified in the report.

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Test Result ..... **Pass**

Date of Test: Aug. 11, 2026 – Aug. 26, 2026

Prepared by: Kevin Pan
Project Engineer

Reviewed by: Silver Wan
Project Supervisor

Approved by: Jason Zhou
Technical Director

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Table of Contents **Page**

1 . TEST SUMMARY 5
1.1 TEST FACILITY 6
1.2 MEASUREMENT UNCERTAINTY 6
2 . GENERAL INFORMATION 7
2.1 GENERAL DESCRIPTION OF EUT 7
2.2 DESCRIPTION OF TEST MODES 8
2.3 DESCRIPTION OF TEST SETUP 9
2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL 10
2.5 MEASUREMENT INSTRUMENTS LIST 11
3 . EMC EMISSION TEST 12
3.1 CONDUCTED EMISSION MEASUREMENT 12
3.1.1 POWER LINE CONDUCTED EMISSION 12
3.1.2 TEST PROCEDURE 13
3.1.3 TEST SETUP 13
3.1.4 EUT OPERATING CONDITIONS 13
3.1.5 TEST RESULTS 14
3.2 RADIATED EMISSION MEASUREMENT 16
3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT 16
3.2.2 TEST PROCEDURE 16
3.2.3 TEST SETUP 17
3.2.4 EUT OPERATING CONDITIONS 17
3.2.5 TEST RESULTS(30MHz~1000MHz) 18
3.2.6 TEST RESULTS(Above 1GHz) 20
4 . EUT TEST PHOTO 22
ATTACHMENT PHOTOGRAPHS OF EUT 23

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** Issued History **

Revision	Description	Issued Date	Remark
Revision 1.0	Initial Test Report Release	2026/08/26	Jason Zhou

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1. TEST SUMMARY

Test procedures according to the technical standards:

EMC Emission				
Standard	Test Item	Limit	Judgment	Remark
FCC Part 15 Subpart B ANSI C63.4	Conducted Emission	Class A	PASS	
	Radiated Emission	Class A	PASS	

NOTE:

(1) 'N/A' denotes test is not applicable in this Test Report

(2) For client's request and manual description, the test will not be executed.

Note: This equipment has been tested and found to comply with the limits for a Class A digital device, pursuant to part 15 of the FCC Rules. These limits are designed to provide reasonable protection against harmful interference when the equipment is operated in a commercial environment. This equipment generates, uses, and can radiate radio frequency energy and, if not installed and used in accordance with the instruction manual, may cause harmful interference to radio communications. Operation of this equipment in a residential area is likely to cause harmful interference in which case the user will be required to correct the interference at his own expense

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1.1 TEST FACILITY

Shenzhen HUAK Testing Technology Co., Ltd.
Add. : 1-2/F., Building B2, Junfeng Zhongcheng Zhizao Innovation Park, Heping, Fuhai Street, Bao'an District, Shenzhen, Guangdong, China

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement **y** ± **U** , where expended uncertainty **U** is based on a standard uncertainty multiplied by a coverage factor of **k=2** , providing a level of confidence of approximately **95** %.

A. Conducted Measurement :

Measurement Frequency Range	Uncertainty	NOTE
150kHz ~ 30MHz	±2.22dB	

B. Radiated Measurement :

Measurement Frequency Range	Uncertainty	NOTE
30 ~ 1000MHz	±3.60dB	
1 ~ 6GHz	±3.86dB	

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2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Product Name	ED-CLAWBOX
Product Model	ED-CLAWBOX
Series Model	N/A
Model Difference	N/A
Product Description	The EUT is a ED-CLAWBOX. Operating frequency: N/A Connecting I/O port: N/A
Power Source	DC Voltage
Power Rating	DC 5V (Voltage operating range: DC 4.75V ~ DC 5.25V)

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2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Working

For Conducted Test	
Final Test Mode	Description
Mode 1	Working

For Radiated Test	
Final Test Mode	Description
Mode 1	Working

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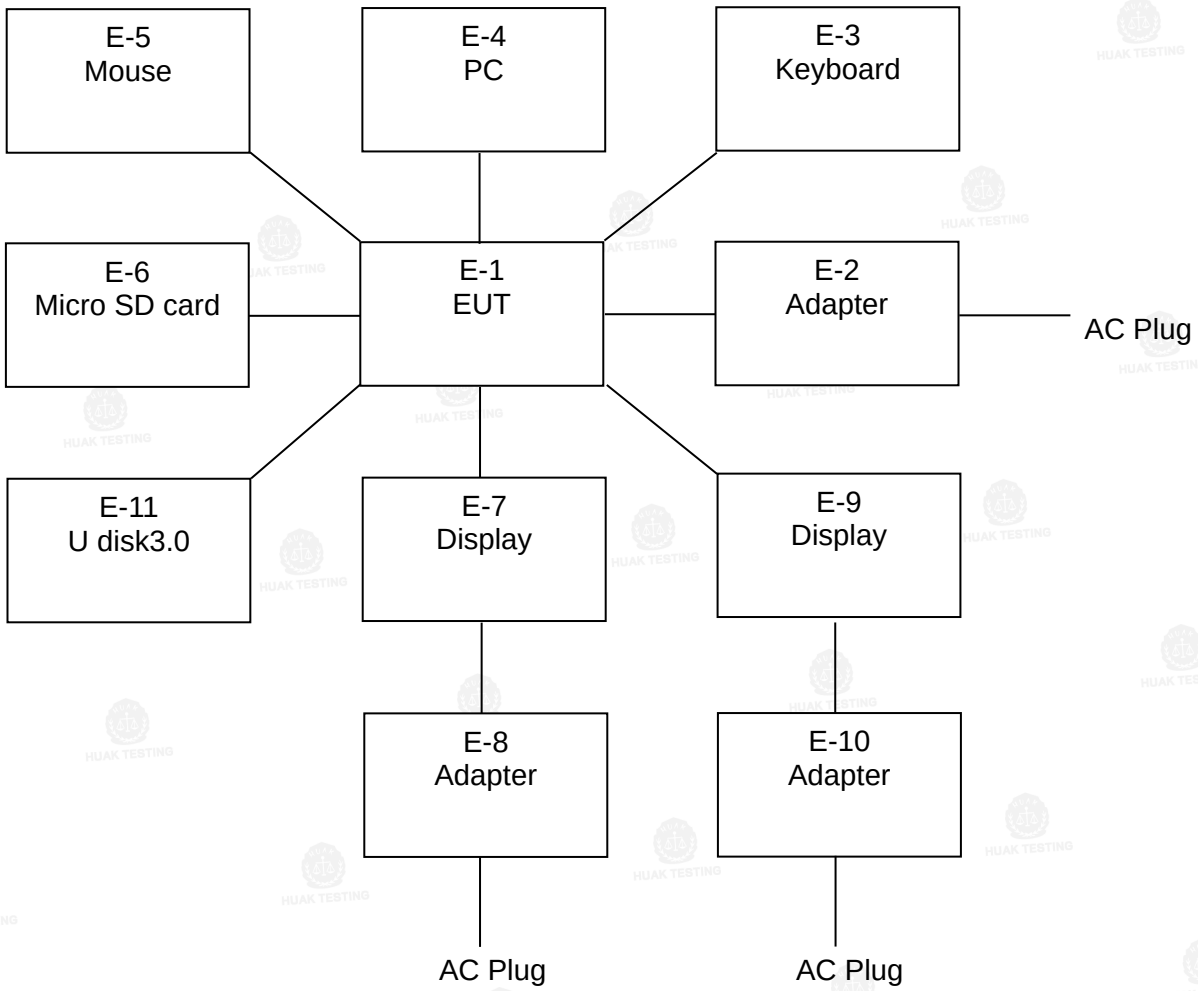
2.3 DESCRIPTION OF TEST SETUP

Mode 1:



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2.4 DESCRIPTION TEST PERIPHERAL AND EUT PERIPHERAL

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Trade Mark	Model/Type No.	Series No.	Note
E-1	ED-CLAWBOX	EDATEC	ED-CLAWBOX	N/A	EUT
E-2	Adapter	N/A	27W USB-C Power Supply US	N/A	
E-3	Keyboard	N/A	N/A	N/A	
E-4	PC	Lenovo	ThinkPad E14 Gen5	N/A	
E-5	Mouse	N/A	N/A	N/A	
E-6	Micro SD card	N/A	N/A	N/A	
E-7	Display	AOC	U2879VF	N/A	
E-8	Adapter	AOC	ADPC2065	N/A	
E-9	Display	PHILIPS	279E1	N/A	
E-10	Adapter	PHILIPS	ADPC2065	N/A	
E-11	U disk3.0	N/A	N/A	N/A	

Item	Shielded Type	Ferrite Core	Length	Note

Note:

(1) The support equipment was authorized by Declaration of Confirmation.

(2) For detachable type I/O cable should be specified the length in cm in『Length』column.

(3) “YES” is means “shielded” “with core”; “NO” is means “unshielded” “without core”.

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2.5 MEASUREMENT INSTRUMENTS LIST

Item	Test Equipment	Manufacturer	Type No.	Serial No.	Calibration Date	Cal. Due
1.	L.I.S.N.	R&S	ENV216	HKE-002	2026.02.11	2027.02.10
2.	L.I.S.N.	R&S	ENV216	HKE-059	2026.02.04	2027.02.03
3.	EMI Test Receiver	R&S	ESR-7	HKE-005	2026.02.06	2027.02.05
4.	Spectrum Analyzer	Agilent	N9020A	HKE-048	2026.02.06	2027.02.05
5.	Amplifier	Schwarzbeck	EMC051845SE	HKE-006	2026.02.06	2027.02.05
6.	Amplifier	SCHWARZBECK	BBV9745	HKE-168	2026.02.04	2027.02.03
7.	6d Attenuator	Pasternack	6db	HKE-185	2026.02.06	2027.02.05
8.	EMI Test Receiver	R&S	ESR-7	HKE-161	2026.02.06	2027.02.05
9.	Broadband Antenna	Schwarzbeck	VULB9168	HKE-167	2026.02.06	2028.02.05
10.	Loop Antenna	COM-POWER	AL-130R	HKE-014	2026.02.06	2028.02.05
11.	Horn antenna	Schwarzbeck	9120D	HKE-013	2026.02.06	2028.02.05
12.	Radiated test software	Tonscend	JS32-RE 5.0.0	HKE-082	/	/
13.	Radiated test software	Tonscend	JS32-RE 5.0.0	HKE-193	/	/

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3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION (Frequency Range 150kHz~30MHz)

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)	
	Quasi-peak	Average	Quasi-peak	Average
0.15 ~ 0.5	79.00	66.00	66 ~ 56 *	56 ~ 46 *
0.50 ~ 5.0	73.00	60.00	56.00	46.00
5.0 ~ 30.0	73.00	60.00	60.00	50.00

Note:

(1) The tighter limit applies at the band edges.

(2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz

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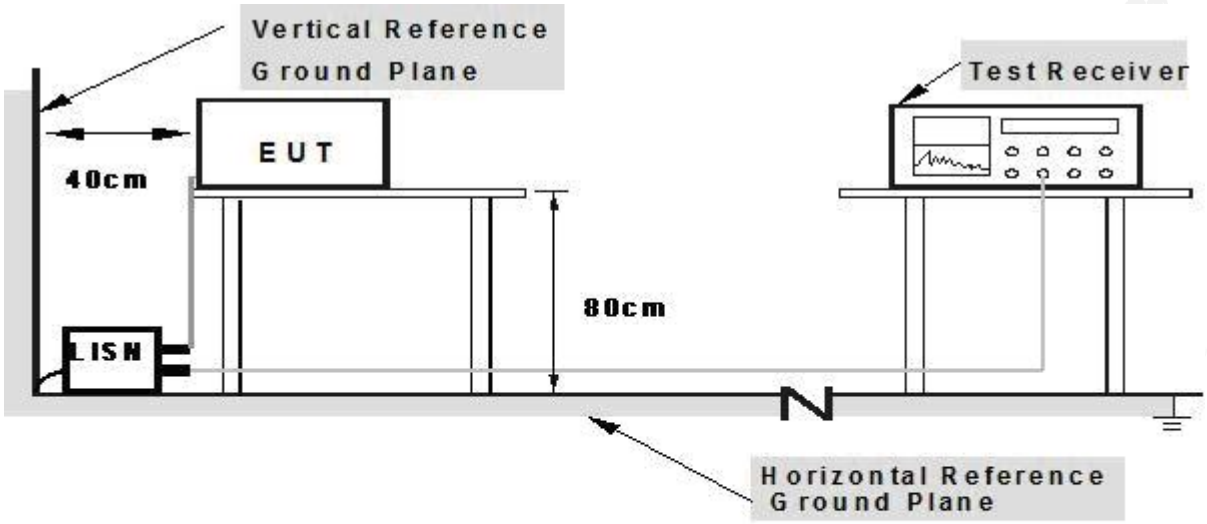
3.1.2 TEST PROCEDURE

a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
d. LISN at least 80 cm from nearest part of EUT chassis.
e. For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.3 TEST SETUP



Note: 1.Support units were connected to second LISN.
2.Both of LISNs (AMN) are 80 cm from EUT and at least 80 from other units and other metal planes

3.1.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.

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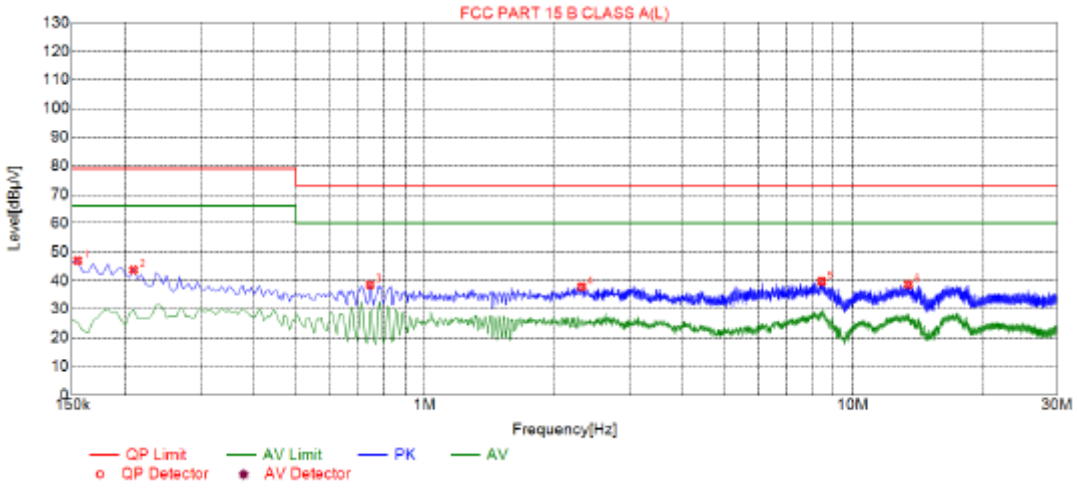
3.1.5 TEST RESULTS

EUT :	ED-CLAWBOX	Model Name. :	ED-CLAWBOX
Temperature :	24.2 ℃	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2026-08-17
Test Mode :	Mode 1	Polarization :	L
Test Voltage :	DC 5.1V From Adapter		



Suspected List

NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Reading [dBµV]	Detector	Type
1	0.1545	46.96	19.84	79.00	32.04	27.12	PK	L
2	0.2085	43.72	19.75	79.00	35.28	23.97	PK	L
3	0.7440	38.50	19.94	73.00	34.50	18.56	PK	L
4	2.3235	37.82	20.09	73.00	35.18	17.73	PK	L
5	8.4435	39.69	20.75	73.00	33.31	18.94	PK	L
6	13.4700	38.67	21.80	73.00	34.33	16.87	PK	L

Remark: Margin = Limit – Level

Correction factor = Cable lose + LISN insertion loss

Level=Test receiver reading + correction factor

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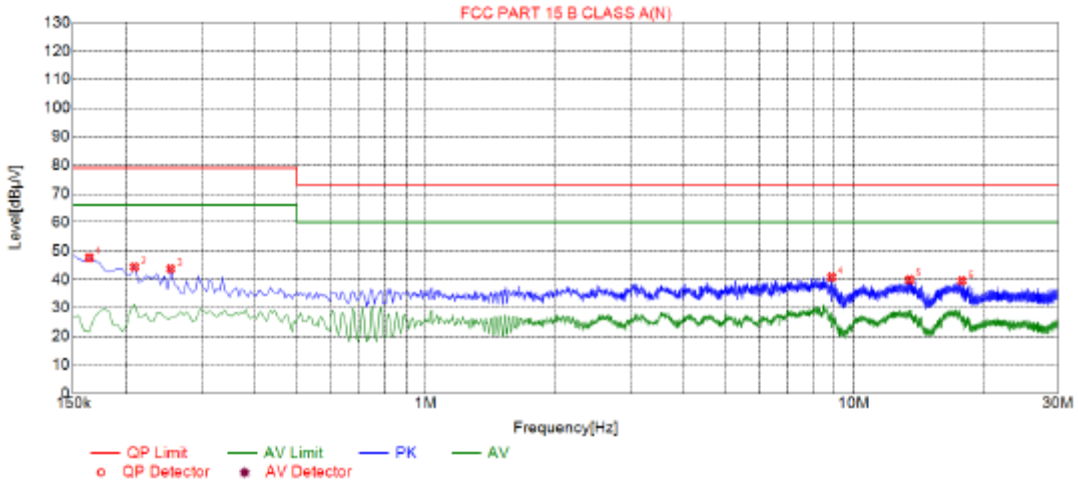
EUT：	ED-CLAWBOX	Model Name. ：	ED-CLAWBOX
Temperature：	24.2 ℃	Relative Humidity：	54%
Pressure：	1010 hPa	Test Date：	2026-08-17
Test Mode：	Mode 1	Polarization：	N
Test Voltage ：	DC 5.1V From Adapter		



Suspected List

NO.	Freq. [MHz]	Level [dBµV]	Factor [dB]	Limit [dBµV]	Margin [dB]	Reading [dBµV]	Detector	Type
1	0.1635	47.63	19.90	79.00	31.37	27.73	PK	N
2	0.2085	44.41	19.76	79.00	34.59	24.65	PK	N
3	0.2535	43.72	19.79	79.00	35.28	23.93	PK	N
4	8.8755	40.83	20.91	73.00	32.17	19.92	PK	N
5	13.4925	39.86	21.67	73.00	33.14	18.19	PK	N
6	17.8845	39.50	22.59	73.00	33.50	16.91	PK	N

Remark: Margin = Limit – Level

Correction factor = Cable lose + LISN insertion loss

Level=Test receiver reading + correction factor

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3.2 RADIATED EMISSION MEASUREMENT

3.2.1 LIMITS OF RADIATED EMISSION MEASUREMENT

FREQUENCY (MHz)	Class A (at 10m)	Class B (at 3m)
	dBuV/m	dBuV/m
30 ~ 88	39.0	40.0
88 ~ 216	43.5	43.5
216 ~ 960	46.5	46.0
Above 960	49.5	54.0

Notes:

(1) The tighter limit applies at the band edges.

3.2.2 TEST PROCEDURE

a. The measured distance is 3m.

b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.

c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

d. The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured, above 1G Average detector mode will be instead.

e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP(AV) Limits and then no additional QP Mode measurement performed.

f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

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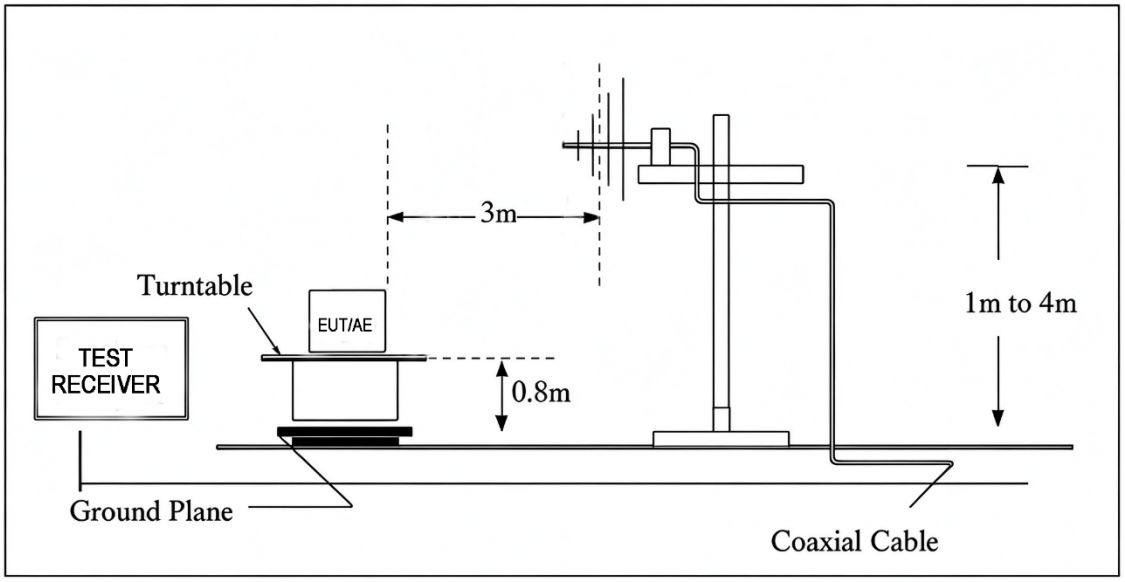
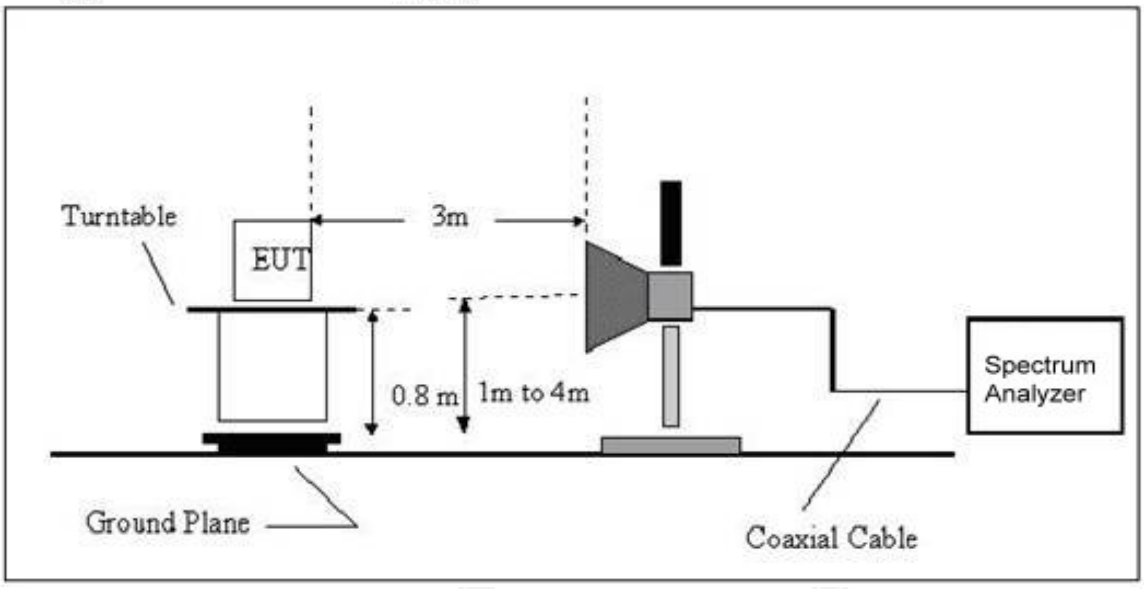
3.2.3 TEST SETUP

(A) Radiated Emission Test Set-Up Frequency Below 1 GHz



(B) Radiated Emission Test Set-Up Frequency Above 1GHz



3.2.4 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **2.3** Unless otherwise a special operating condition is specified in the follows during the testing.

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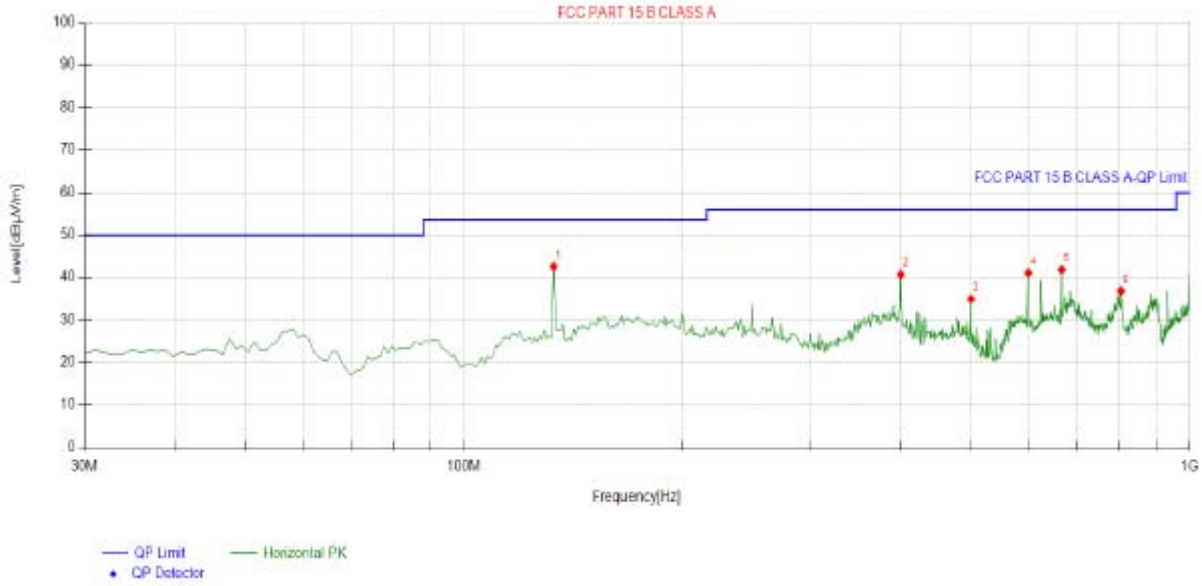
3.2.5 TEST RESULTS(30MHz~1000MHz)

EUT：	ED-CLAWBOX	Model Name ：	ED-CLAWBOX
Temperature：	24.3 ℃	Relative Humidity：	54%
Pressure：	1010 hPa	Test Date：	2026-08-17
Test Mode ：	Mode 1	Polarization：	Horizontal
Test Power ：	DC 5.1V From Adapter		



Suspected List									
NO.	Freq. [MHz]	Factor [dB]	Reading [dBµV/m]	Level [dBµV/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	132.92292	-20.22	62.73	42.51	53.50	10.99	100	63	Horizontal
2	399.93994	-18.34	59.07	40.73	56.00	15.27	100	288	Horizontal
3	499.94995	-17.17	52.07	34.90	56.00	21.10	100	116	Horizontal
4	599.95996	-15.47	56.55	41.08	56.00	14.92	100	303	Horizontal
5	666.95695	-14.70	56.51	41.81	56.00	14.19	100	118	Horizontal
6	804.83483	-13.47	50.26	36.79	56.00	19.21	100	83	Horizontal

Final Data List

Remark: Factor = Cable loss + Antenna factor – Preamplifier; Level = Reading + Factor; Margin = Limit – Level;

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EUT：	ED-CLAWBOX	Model Name ：	ED-CLAWBOX
Temperature：	24.3 ℃	Relative Humidity：	54%
Pressure：	1010 hPa	Test Date：	2026-08-17
Test Mode ：	Mode 1	Polarization：	Vertical
Test Power ：	DC 5.1V From Adapter		



Suspected List

NO.	Freq. [MHz]	Factor [dB]	Reading [dBµV/m]	Level [dBµV/m]	Limit [dBµV/m]	Margin [dB]	Height [cm]	Angle [°]	Polarity
1	43.593594	-17.93	54.11	36.18	50.00	13.82	100	274	Vertical
2	64.954955	-20.24	55.56	35.32	50.00	14.68	100	73	Vertical
3	132.92292	-20.22	59.53	39.31	53.50	14.19	100	137	Vertical
4	599.95996	-15.47	56.75	41.28	56.00	14.72	100	180	Vertical
5	625.20520	-15.12	54.39	39.27	56.00	16.73	100	187	Vertical
6	666.95695	-14.70	58.04	43.34	56.00	12.66	100	49	Vertical

Final Data List

Remark: Factor = Cable loss + Antenna factor – Preamplifier; Level = Reading + Factor; Margin = Limit – Level;

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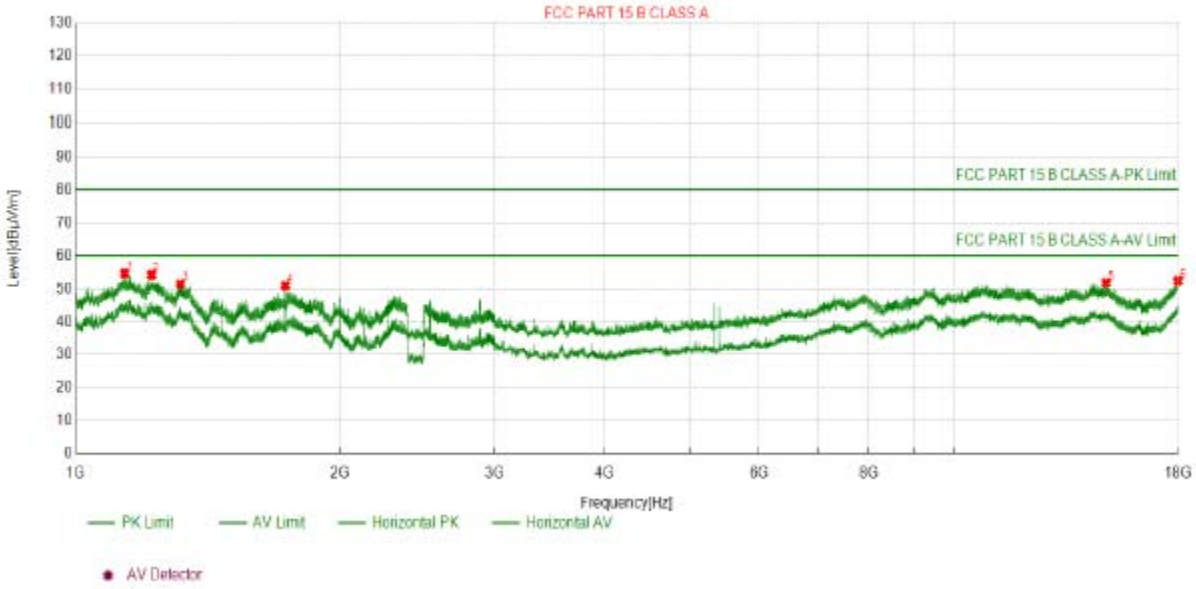
3.2.6 TEST RESULTS(Above 1GHz)

EUT :	ED-CLAWBOX	Model Name :	ED-CLAWBOX
Temperature :	24.3 ℃	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2026-08-17
Test Mode :	Mode 1	Polarization :	Horizontal
Test Power :	DC 5.1V From Adapter		



Suspected Data List

NO.	Freq. [MHz]	Reading [dBµV/m]	PK Level [dBµV/m]	Factor [dB]	PK Limit [dBµV/m]	PK Margin [dB]	Height [cm]	Angle [°]	Polarity
1	1137.814	74.37	54.68	-19.69	80.00	25.32	100	56	Horizontal
2	1220.422	73.38	54.25	-19.13	80.00	25.75	100	332	Horizontal
3	1315.832	70.11	51.44	-18.67	80.00	28.56	100	292	Horizontal
4	1733.073	69.10	50.96	-18.14	80.00	29.04	100	285	Horizontal
5	14897.690	48.38	51.81	3.43	80.00	28.19	100	322	Horizontal
6	17983.498	45.22	52.41	7.19	80.00	27.59	100	130	Horizontal

Final Data List

Remark: Factor = Cable loss + Antenna factor – Preamplifier; Level = Reading + Factor; Margin = Limit – Level;

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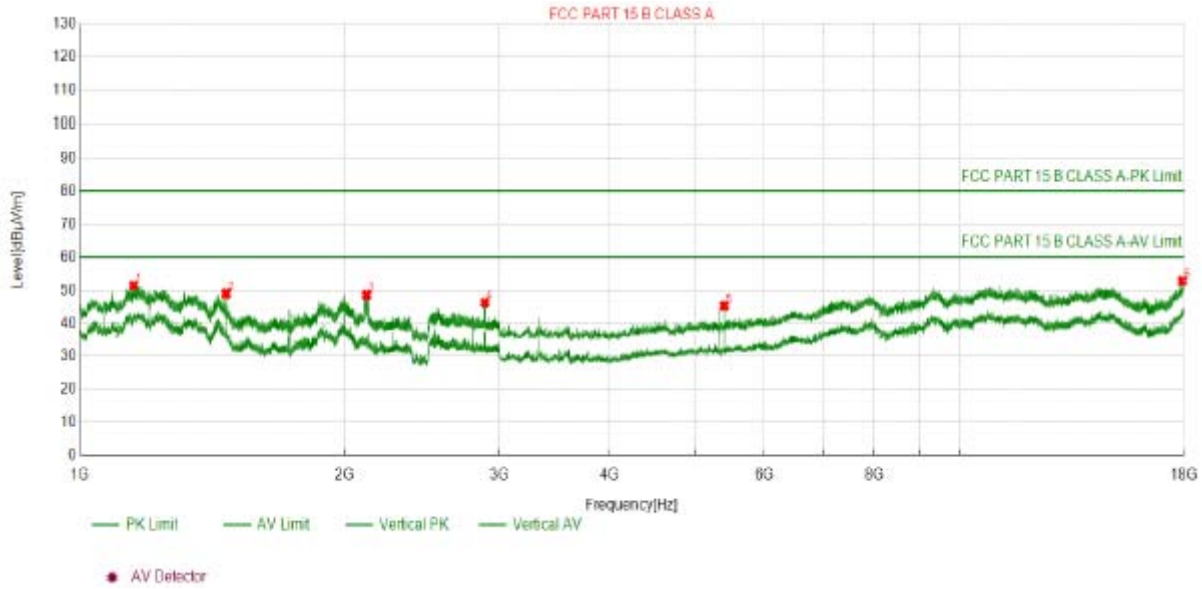
EUT :	ED-CLAWBOX	Model Name :	ED-CLAWBOX
Temperature :	24.3 ℃	Relative Humidity :	54%
Pressure :	1010 hPa	Test Date :	2026-08-17
Test Mode :	Mode 1	Polarization :	Vertical
Test Power :	DC 5.1V From Adapter		



Suspected Data List

NO.	Freq. [MHz]	Reading [dBµV/m]	PK Level [dBµV/m]	Factor [dB]	PK Limit [dBµV/m]	PK Margin [dB]	Height [cm]	Angle [°]	Polarity
1	1151.815	71.11	51.49	-19.62	80.00	28.51	100	67	Vertical
2	1466.447	67.50	48.99	-18.51	80.00	31.01	100	55	Vertical
3	2118.512	64.23	48.57	-15.66	80.00	31.43	100	101	Vertical
4	2885.589	59.24	46.27	-12.97	80.00	33.73	100	67	Vertical
5	5400.240	55.55	45.31	-10.24	80.00	34.69	100	350	Vertical
6	17912.991	46.50	52.83	6.33	80.00	27.17	100	279	Vertical

Final Data List

Remark: Factor = Cable loss + Antenna factor – Preamplifier; Level = Reading + Factor; Margin = Limit – Level;

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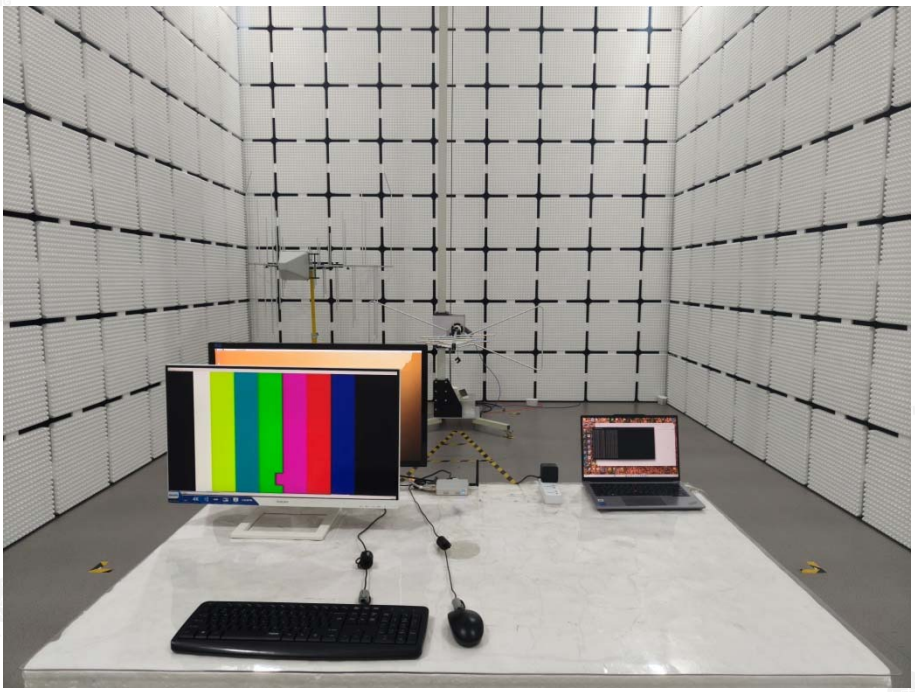
4. **EUT TEST PHOTO**

Conducted Emission



Radiated Emission



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ATTACHMENT PHOTOGRAPHS OF EUT

Photo 1



Photo 2



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Photo 3



Photo 4



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Photo 5



Photo 6

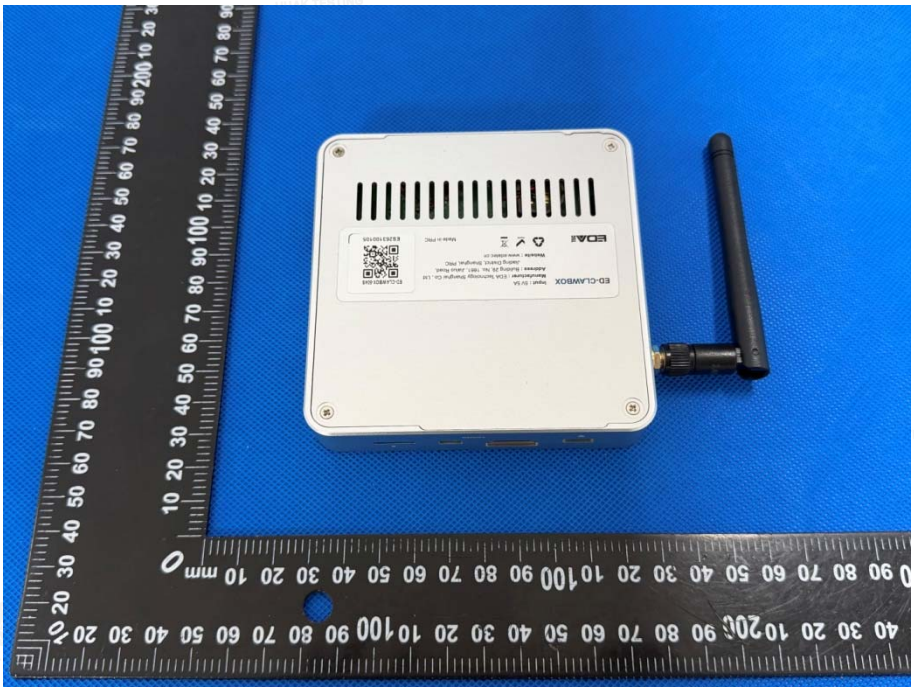

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Photo 7



Photo 8



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Photo 9

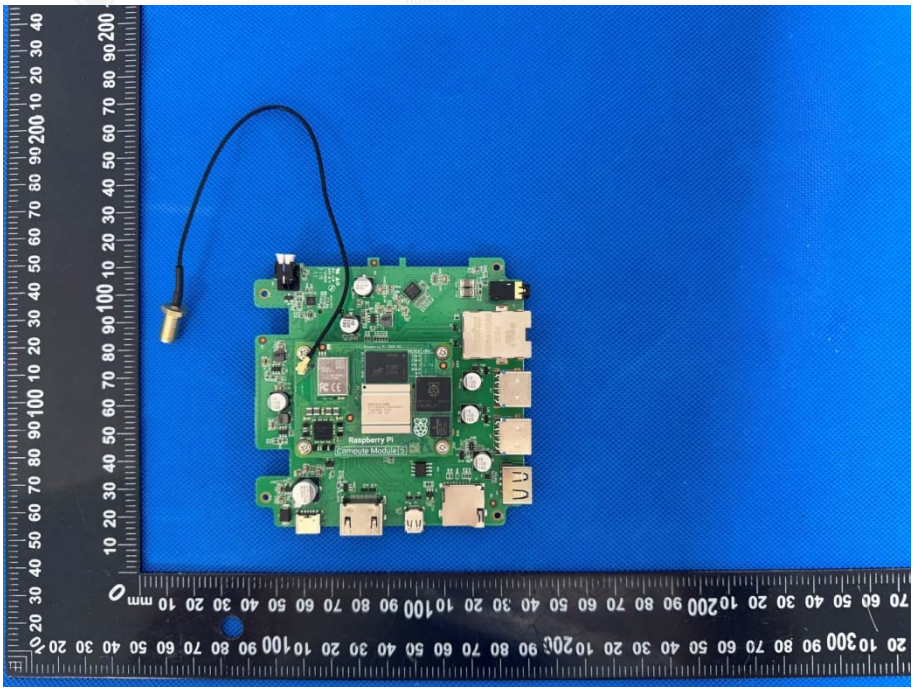

Photo 10

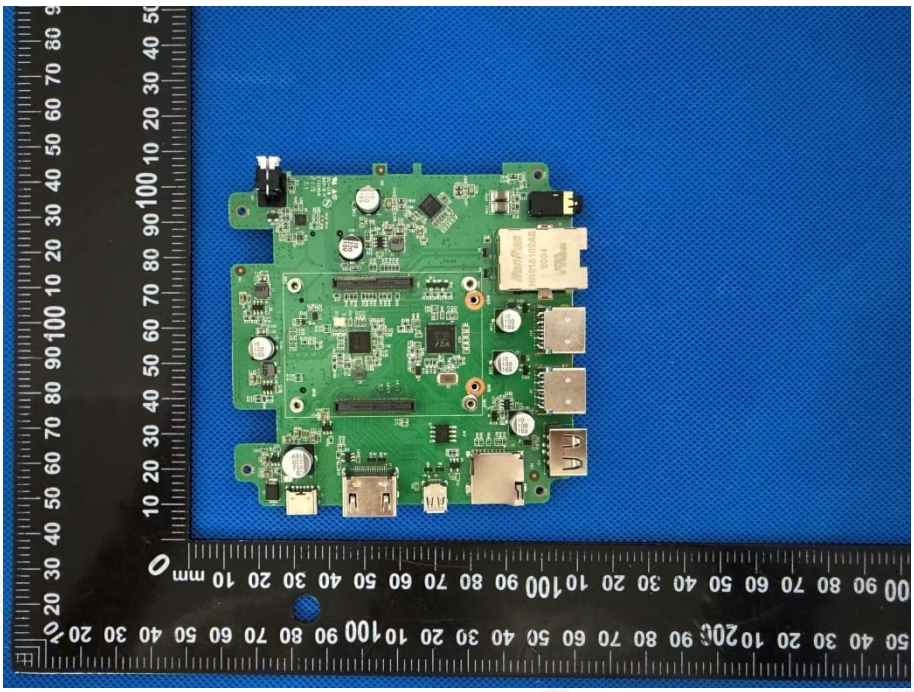

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Photo 11

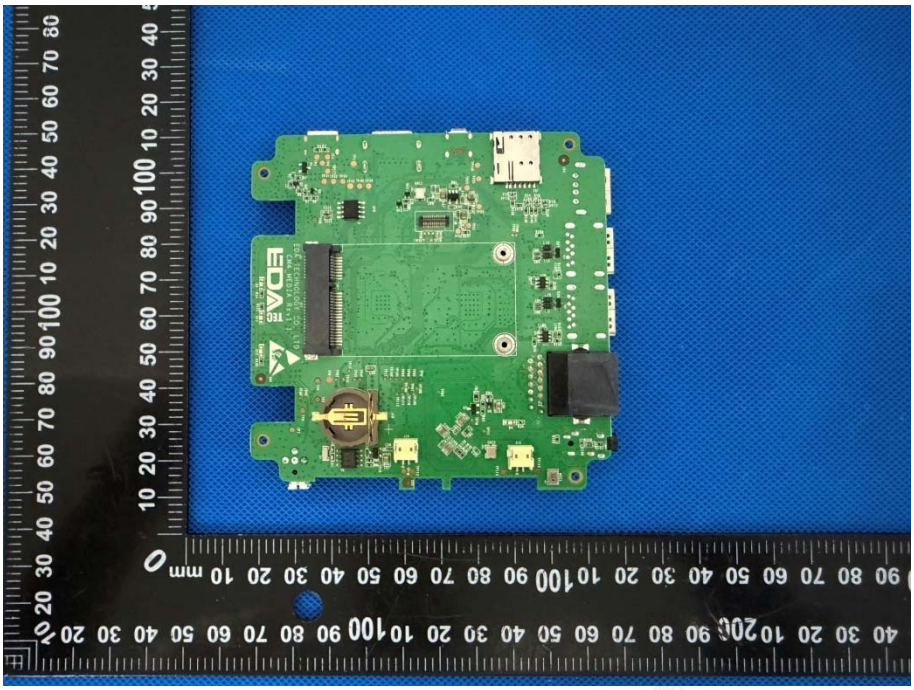

Photo 12

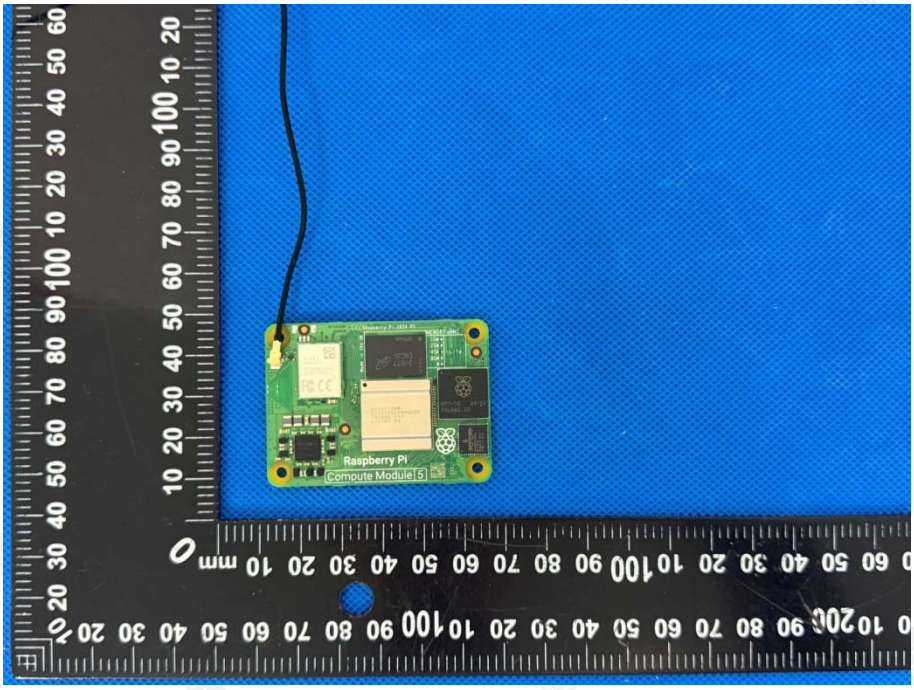

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Photo 13

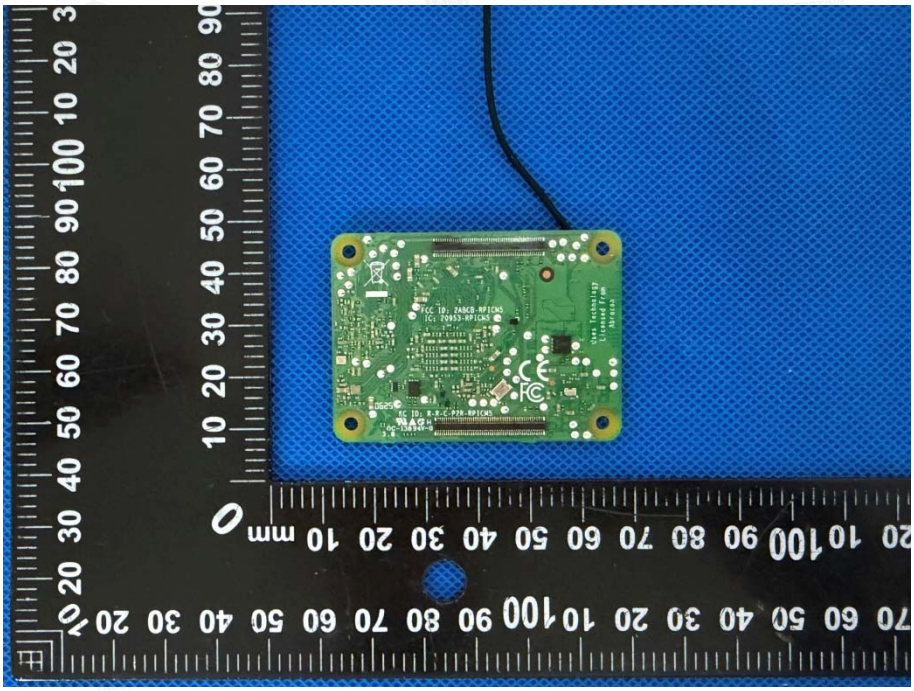

Photo 14



----------End of report----------

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